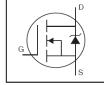
HEXFET® Power MOSFET



- Logic -Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ©
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free

Description

$V_{ exttt{DSS}}$	100V
R _{DS(on)}	0.18Ω
l _n	8.1A



		—
G	D	S
Gate	Drain	Source

advanced processing techniques to achieve extremely low onresistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

Fifth Generation HEXFETs from International Rectifier utilize

The TO-220 Full Pak eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heat sink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heat sink

using a single clip or by a single screw fixing.

Page Dort Number	Part Number Package Type Standard Pack		d Pack	Orderable Part Number	
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
IRLI520NPbF	TO-220 Full-Pak	Tube	50	IRLI520NPbF	

Absolute Maximum Ratings					
Symbol	Symbol Parameter		Units		
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	8.1			
D @ T _C = 100°C Continuous Drain Current, V _{GS} @ 10V		5.7	A		
ДМ	Pulsed Drain Current ①⑥	35			
P _D @T _C = 25°C	Maximum Power Dissipation	30	W		
	Linear Derating Factor	0.20	W/°C		
V_{GS}	Gate-to-Source Voltage	± 16	V		
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②⑥	85	mJ		
AR	Avalanche Current ①⑥	6.0	A		
E _{AR}	Repetitive Avalanche Energy ①	3.0	mJ		
dv/dt	Peak Diode Recovery dv/dt36	5.0	V/ns		
Γ _J	Operating Junction and	-55 to + 175			
$\Gamma_{ m STG}$	Storage Temperature Range		°C		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300			
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		5.0	°C/W
$R_{\theta JA}$	Junction-to-Ambient		65	C/VV

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.11		V/°C	Reference to 25°C, I _D = 1mA ®
. ,				0.18		$V_{GS} = 10V, I_D = 6.0A$
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.22	Ω	$V_{GS} = 5.0V, I_D = 6.0A$
= = (=::)				0.26		$V_{GS} = 4.0V, I_D = 5.0A$
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	3.1				V _{DS} = 25V, I _D = 6.0A®
1	Drain to Course Leakage Current	Ī ——		25		$V_{DS} = 100V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -16V$
Q_g	Total Gate Charge			20		$I_{D} = 6.0A$
Q_{gs}	Gate-to-Source Charge			4.6	nC	V _{DS} = 80V
Q_{gd}	Gate-to-Drain Charge			10		V _{GS} = 5.0V , See Fig. 6 and 13④⑥
t _{d(on)}	Turn-On Delay Time		40			$V_{DD} = 50V$
t _r	Rise Time		35			$I_{D} = 6.0A$
t _{d(off)}	Turn-Off Delay Time		23		ns	R_{G} = 11 Ω , V_{GS} = 5.0 V
t _f	Fall Time		22			R _D = 8.2Ω, See Fig. 10④⑥
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance		7.5		nH	from package and center of die contact
C _{iss}	Input Capacitance		440			V _{GS} = 0V
C _{oss}	Output Capacitance	l	97		nE	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		50		pF	f = 1.0MHz, See Fig. 5®
С	Drain to Sink Capacitance		12			f = 1.0MHz

Source-Drain Ratings and Characteristics

	rum rumgo una onaraotoriotico				,	T
	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			8.1		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ① ⑤			35		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 6.0A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		110	160	ns	$T_J = 25^{\circ}C$, $I_F = 6.0A$
Q _{rr}	Reverse Recovery Charge		410	620	nC	di/dt = 100A/µs ④⑥
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^{\circ}C$, L = 4.7mH, $R_G = 25\Omega$, $I_{AS} = 6.0A$ (See fig. 12)
- $\label{eq:local_local_local_local} \text{ } \textbf{3} \textbf{I}_{SD} \leq 6.0 A, \text{ } \text{di/dt} \leq 340 A/\mu s, \text{ } \textbf{V}_{DD} \leq \textbf{V}_{(BR)DSS}, \text{ } \textbf{T}_{J} \leq 175 ^{\circ} \text{C}.$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ t=60s, *f*=60Hz
- © Uses IRL520N data and test conditions.



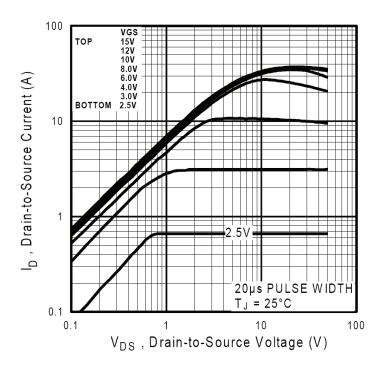


Fig. 1 Typical Output Characteristics

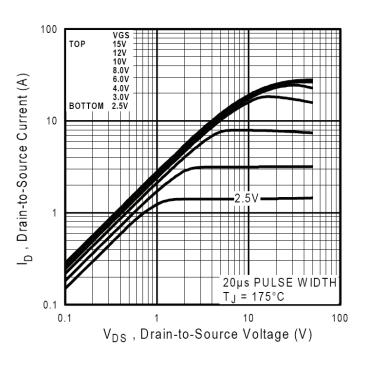


Fig. 2 Typical Output Characteristics

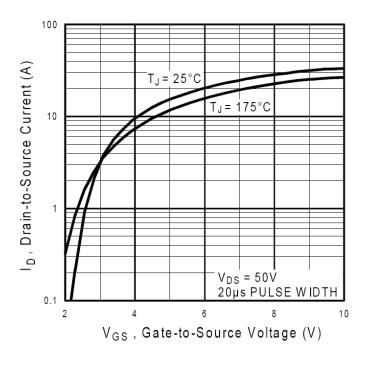


Fig. 3 Typical Transfer Characteristics

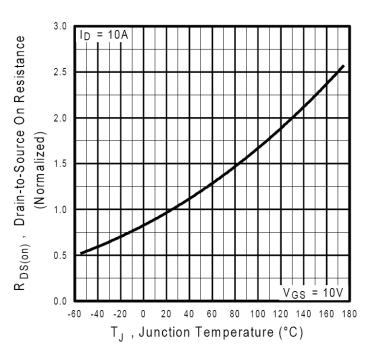


Fig. 4 Normalized On-Resistance vs. Temperature

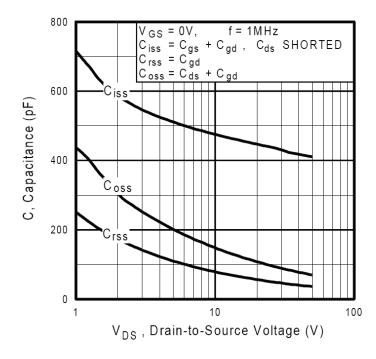


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

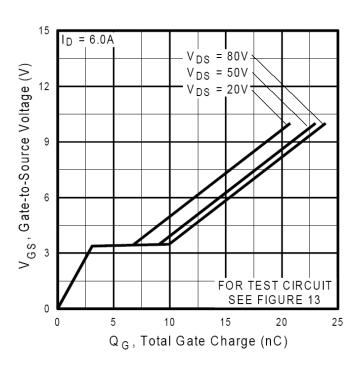


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

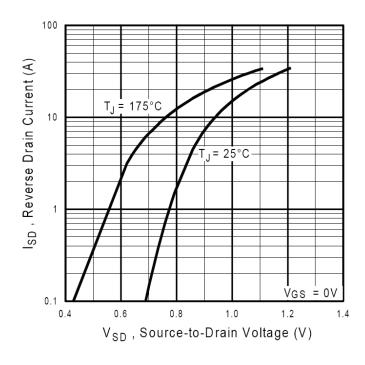


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

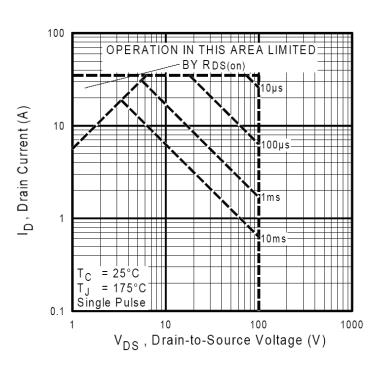


Fig 8. Maximum Safe Operating Area



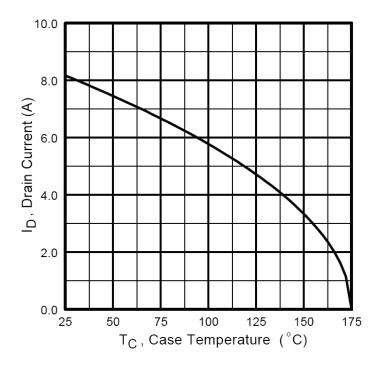


Fig 9. Maximum Drain Current vs. Case Temperature

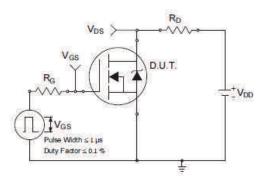


Fig 10a. Switching Time Test Circuit

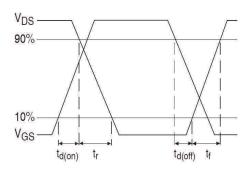


Fig 10b. Switching Time Waveforms

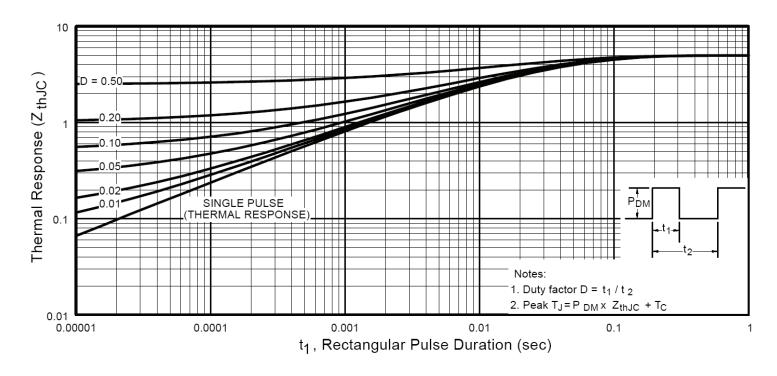


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



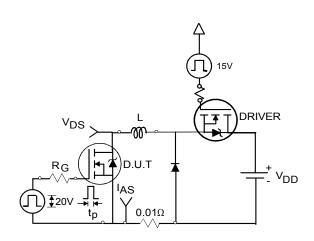


Fig 12a. Unclamped Inductive Test Circuit

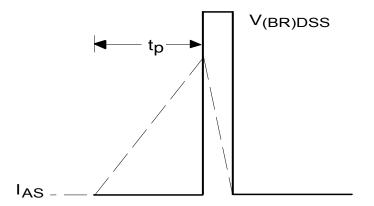


Fig 12b. Unclamped Inductive Waveforms

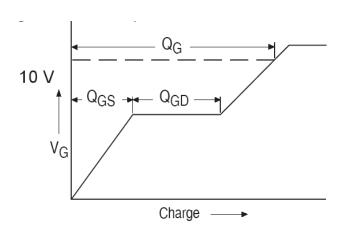


Fig 13a. Gate Charge Waveform

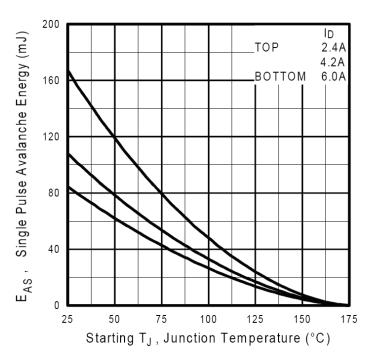


Fig 12c. Maximum Avalanche Energy vs. Drain Current

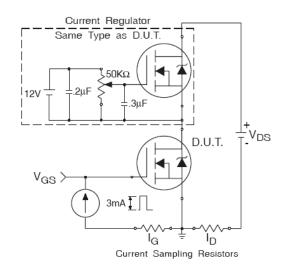
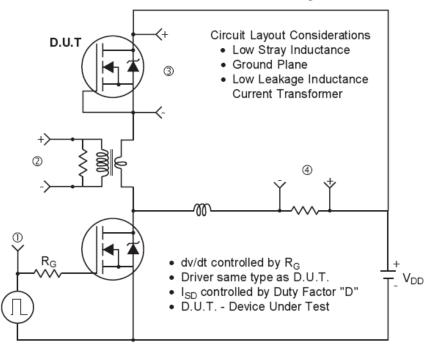


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



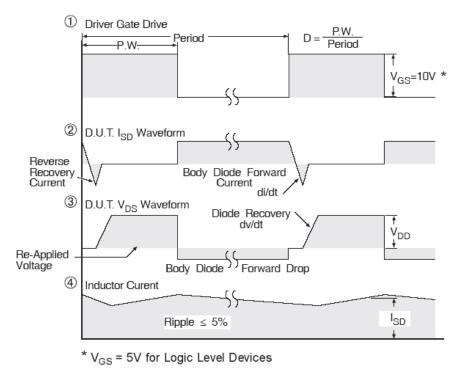
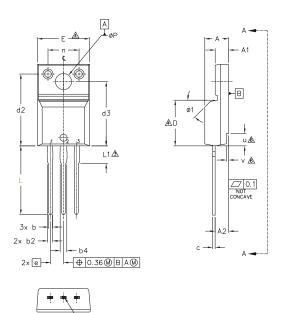
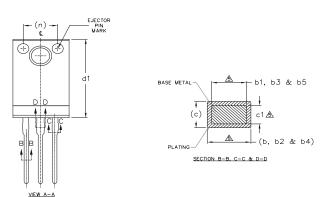


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

2,0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.

<u> 名</u>

DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.

 $\cancel{6.0}$ STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.

7.0 CONTROLLING DIMENSION: INCHES.

S Y	DIMENSIONS				N	
M	MILLIM		1	INCHES		
Ö					O T E S	
L	MIN.	MAX.	MIN.	MAX.	s	
Α	4.57	4.83	.180	.190		
Α1	2.57	2.82	.101	.111		
A2	2.51	2.92	.099	.115		
Ь	0.61	0.94	.024	.037		
ь1	0.61	0.89	.024	.035	5	
b2	0.76	1.27	.030	.050		
ь3	0.76	1.22	.030	.048	5	
Ь4	1.02	1.52	.040	.060		
b5	1.02	1.47	.040	.058	5	
С	0.33	0.63	.013	.025		
с1	0.33	0.58	.013	.023	5	
D	8.66	9.80	.341	.386	4	
d1	15.80	16.13	.622	.635		
d2	13.97	14.22	.550	.560		
d3	12.29	12.93	.484	.509		
Ε	9.63	10.74	.379	.423	4	
е				BSC		
L	13.21	13.72	.520	.540		
L 1	3.10	3.68	.122	.145	3	
n	6.05	6.60	.238	.260		
ØΡ	3.05	3.45	.120	.136		
u	2.39	2.49	.094	.098	6	
V	0.41	0.51	.016	.020	6	
Ø1	_	45°	_	45°		
	M B O L A A1 A2 b b1 b2 b3 b4 b c c1 D d1 d2 d3 E e L L1 n p P u v	M B O L MIN. A 4.57 A1 2.57 A2 2.51 b 0.61 b1 0.61 b2 0.76 b3 0.76 b4 1.02 c 0.33 c1 0.33 D 8.66 d1 15.80 d2 13.97 d3 12.29 E 9.63 e 2.54 L 13.21 L1 3.10 n 6.05 øP 3.05 u 2.39 v 0.41	M B O L MIN. MAX. A 4.57 4.83 A1 2.57 2.82 A2 2.51 2.92 b 0.61 0.94 b1 0.61 0.89 b2 0.76 1.27 b3 0.76 1.22 b4 1.02 1.52 b5 1.02 1.47 c 0.33 0.63 c1 0.33 0.58 D 8.66 9.80 d1 15.80 16.13 d2 13.97 14.22 d3 12.29 12.93 E 9.63 10.74 e 2.54 BSC L 13.21 13.72 L1 3.10 3.68 n 6.05 6.60 ØP 3.05 3.45 u 2.39 2.49 v 0.41 0.51	M B MILLIMETERS INC O MIN. MAX. MIN. A 4.57 4.83 .180 A1 2.57 2.82 .101 A2 2.51 2.92 .099 b 0.61 0.89 .024 b1 0.61 0.89 .024 b2 0.76 1.27 .030 b3 0.76 1.22 .030 b4 1.02 1.52 .040 b5 1.02 1.47 .040 c 0.33 0.63 .013 c1 0.33 0.58 .013 D 8.66 9.80 .341 d1 15.80 16.13 .622 d3 12.29 12.93 .484 E 9.63 10.74 .379 e 2.54 BSC .100 L 13.21 13.72 .520 L 3.10	M B O L MILLIMETERS INCHES A 4.57 4.83 .180 .190 A1 2.57 2.82 .101 .111 A2 2.51 2.92 .099 .115 b 0.61 0.94 .024 .037 b1 0.61 0.89 .024 .035 b2 0.76 1.27 .030 .050 b3 0.76 1.22 .030 .048 b4 1.02 1.52 .040 .060 b5 1.02 1.47 .040 .058 c 0.33 0.63 .013 .025 c1 0.33 0.58 .013 .023 D 8.66 9.80 .341 .386 d1 15.80 16.13 .622 .635 d2 13.97 14.22 .550 .560 d3 12.29 12.93 .484 .509 E	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2. – DRAIN

3.- SOURCE

IGBTs, CoPACK

1.- GATE

2.- COLLECTOR

3.- EMITTER

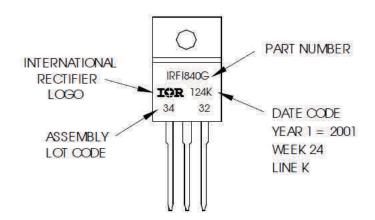
TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY

LOT CODE 3432

ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to website at http://www.irf.com/package/

2017-04-27



Qualification Information

Qualification Level	Industrial (per JEDEC JESD47F) †			
Moisture Sensitivity Level	TO-220 Full-Pak N/A			
RoHS Compliant	Yes			

† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments	
4/27/17	 Changed datasheet with Infineon logo - all pages. Corrected Package Outline on page 8. 	
	Added disclaimer on last page.	

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